Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/747,805	NARENDRA ET AL.

Examiner
Thien F. Tran

2811

Art Unit

SEARCHED					
Subclass	Date	Examiner			
707,717 719,778	10/25/2005	π			
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	Subclass 707,717	Subclass Date 707,717 10/25/2005			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		 			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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